



## Monolithic N-Channel JFET Duals

| PRODUCT SUMMARY |                   |                       |                   |                |                                |
|-----------------|-------------------|-----------------------|-------------------|----------------|--------------------------------|
| Part Number     | $V_{GS(off)}$ (V) | $V_{(BR)GSS}$ Min (V) | $g_{fs}$ Min (mS) | $I_G$ Max (pA) | $ V_{GS1} - V_{GS2} $ Max (mV) |
| 2N5545          | -0.5 to -4.5      | -50                   | 1.5               | -50            | 5                              |
| 2N5546          | -0.5 to -4.5      | -50                   | 1.5               | -50            | 10                             |
| 2N5547          | -0.5 to -4.5      | -50                   | 1.5               | -50            | 15                             |

### FEATURES

- Monolithic Design
- High Slew Rate
- Low Offset/Drift Voltage
- Low Gate Leakage: 3 pA
- Low Noise
- High CMRR: 100 dB

### BENEFITS

- Tight Differential Match vs. Current
- Improved Op Amp Speed, Settling Time Accuracy
- Minimum Input Error/Trimming Requirement
- Insignificant Signal Loss/Error Voltage
- High System Sensitivity
- Minimum Error with Large Input Signal

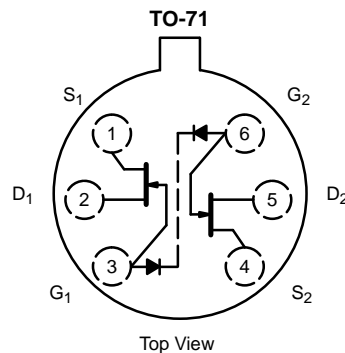
### APPLICATIONS

- Wideband Differential Amps
- High-Speed, Temp-Compensated, Single-Ended Input Amps
- High-Speed Comparators
- Impedance Converters

### DESCRIPTION

The 2N5545/5546/5547 JANTX/JANTXV are monolithic dual n-channel JFETs designed to provide high input impedance ( $I_G < 50$  pA) for general-purpose differential amplifiers. The

2N5545 features minimum system error and calibration (5 mV offset maximum).



### ABSOLUTE MAXIMUM RATINGS

Gate-Drain, Gate-Source Voltage ..... -50 V  
 Gate Current ..... 30 mA  
 Lead Temperature (<sup>1</sup>/<sub>16</sub>" from case for 10 sec.) ..... 300°C  
 Storage Temperature ..... -65 to 200°C  
 Operating Junction Temperature ..... -55 to 150°C

Power Dissipation : Per Side<sup>a</sup> ..... 250 mW  
 Total<sup>b</sup> ..... 500 mW

Notes  
 a. Derate 2 mW/°C above 25°C  
 b. Derate 4 mW/°C above 25°C



| SPECIFICATIONS (T <sub>A</sub> = 25 °C UNLESS OTHERWISE NOTED) |                                              |                                                                                   |                  |        |      |        |      |        |      |            |
|----------------------------------------------------------------|----------------------------------------------|-----------------------------------------------------------------------------------|------------------|--------|------|--------|------|--------|------|------------|
| Parameter                                                      | Symbol                                       | Test Conditions                                                                   | Typ <sup>a</sup> | Limits |      |        |      |        |      | Unit       |
|                                                                |                                              |                                                                                   |                  | 2N5545 |      | 2N5546 |      | 2N5547 |      |            |
|                                                                |                                              |                                                                                   |                  | Min    | Max  | Min    | Max  | Min    | Max  |            |
| <b>Static</b>                                                  |                                              |                                                                                   |                  |        |      |        |      |        |      |            |
| Gate-Source Breakdown Voltage                                  | V <sub>(BR)GSS</sub>                         | I <sub>G</sub> = -1 μA, V <sub>DS</sub> = 0 V                                     | -57              | -50    |      | -50    |      | -50    |      | V          |
| Gate-Source Cutoff Voltage                                     | V <sub>GS(off)</sub>                         | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 0.5 nA                                   | -2               | -0.5   | -4.5 | -0.5   | -4.5 | -0.5   | -4.5 | V          |
| Saturation Drain Current <sup>b</sup>                          | I <sub>DSS</sub>                             | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V                                     | 3                | 0.5    | 8    | 0.5    | 8    | 0.5    | 8    | mA         |
| Gate Reverse Current                                           | I <sub>GSS</sub>                             | V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V                                    | -10              |        | -100 |        | -100 |        | -100 | pA         |
|                                                                |                                              | T <sub>A</sub> = 150 °C                                                           | -20              |        | -150 |        | -150 |        | -150 | nA         |
| Gate Operating Current                                         | I <sub>G</sub>                               | V <sub>DG</sub> = 15 V, I <sub>D</sub> = 200 μA                                   | -3               |        | -50  |        | -50  |        | -50  | pA         |
| Gate-Source Forward Voltage                                    | V <sub>GS(F)</sub>                           | I <sub>G</sub> = 1 mA, V <sub>DS</sub> = 0 V                                      | 0.7              |        |      |        |      |        |      | V          |
| <b>Dynamic</b>                                                 |                                              |                                                                                   |                  |        |      |        |      |        |      |            |
| Common-Source Forward Transconductance <sup>b</sup>            | g <sub>fs</sub>                              | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V<br>f = 1 kHz                        | 2.5              | 1.5    | 6.0  | 1.5    | 6.0  | 1.5    | 6.0  | mS         |
| Common-Source Output Conductance <sup>b</sup>                  | g <sub>os</sub>                              |                                                                                   | 2                |        | 25   |        | 25   |        | 25   | μS         |
| Common-Source Input Capacitance                                | C <sub>iss</sub>                             | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V<br>f = 1 MHz                        | 3.5              |        | 6    |        | 6    |        | 6    | pF         |
| Common-Source Reverse Transfer Capacitance                     | C <sub>rss</sub>                             |                                                                                   | 1.3              |        | 2    |        | 2    |        | 2    |            |
| Equivalent Input Noise Voltage                                 | $\bar{e}_n$                                  | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 200 μA<br>f = 10 Hz                      | 20               |        | 180  |        | 200  |        |      | nV/<br>√Hz |
| Noise Figure                                                   | NF                                           | R <sub>G</sub> = 1 MΩ                                                             | 0.1              |        | 3.5  |        | 5    |        |      | dB         |
| <b>Matching</b>                                                |                                              |                                                                                   |                  |        |      |        |      |        |      |            |
| Differential Gate-Source Voltage                               | V <sub>GS1</sub> - V <sub>GS2</sub>          | V <sub>DG</sub> = 15 V, I <sub>D</sub> = 50 μA                                    |                  |        | 5    |        | 10   |        | 15   | mV         |
|                                                                |                                              | V <sub>DG</sub> = 15 V, I <sub>D</sub> = 200 μA                                   |                  |        | 5    |        | 10   |        | 15   |            |
| Gate-Source Voltage Differential Change with Temperature       | $\frac{\Delta V_{GS1} - V_{GS2} }{\Delta T}$ | V <sub>DG</sub> = 15 V, I <sub>D</sub> = 200 μA<br>T <sub>A</sub> = -55 to 125 °C |                  |        | 10   |        | 20   |        | 40   | μV/<br>°C  |
| Saturation Drain Current Ratio <sup>c</sup>                    | $\frac{I_{DSS1}}{I_{DSS2}}$                  | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V                                     | 0.98             | 0.95   | 1    | 0.9    | 1    | 0.9    | 1    |            |
| Transconductance Ratio <sup>c</sup>                            | $\frac{g_{fs1}}{g_{fs2}}$                    | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 200 μA<br>f = 1 kHz                      | 0.99             | 0.97   | 1    | 0.95   | 1    | 0.9    | 1    |            |
| Differential Output Conductance                                | g <sub>os1</sub> - g <sub>os2</sub>          | V <sub>DG</sub> = 15 V, V <sub>GS</sub> = 0 V<br>f = 1 kHz                        | 0.1              |        | 1    |        | 2    |        | 3    | μS         |
| Differential Gate Current                                      | I <sub>G1</sub> - I <sub>G2</sub>            | V <sub>DG</sub> = 15 V, I <sub>D</sub> = 200 μA<br>T <sub>A</sub> = 125 °C        | 1                |        | 5    |        | 5    |        | 5    | nA         |

**Notes**

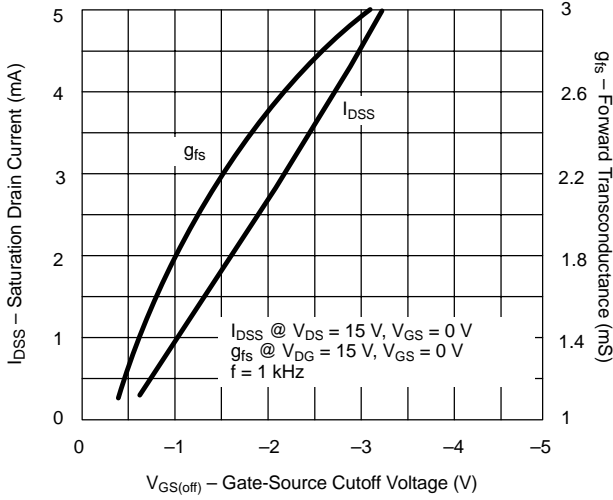
- a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- b. Pulse test: PW ≤ 300 μs duty cycle ≤ 3%.
- c. Assumes smaller value in the numerator.

NQP

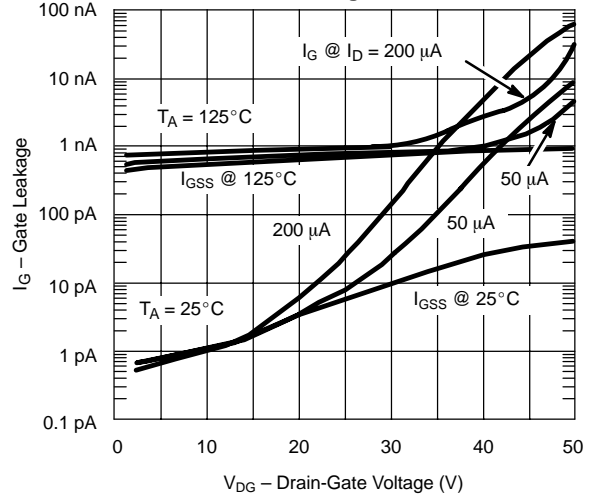


**TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$  UNLESS OTHERWISE NOTED)**

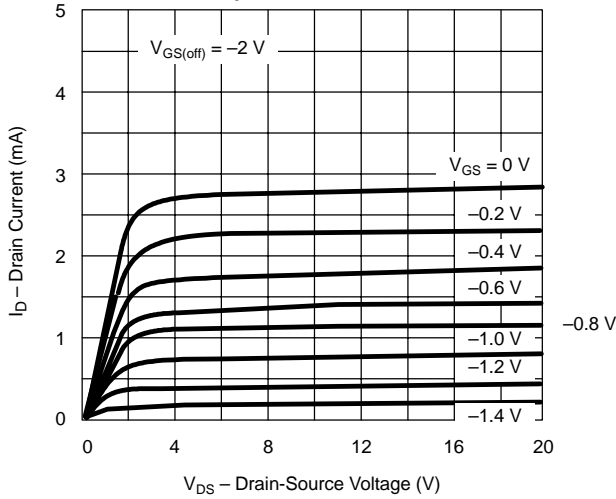
**Drain Current and Transconductance vs. Gate-Source Cutoff Voltage**



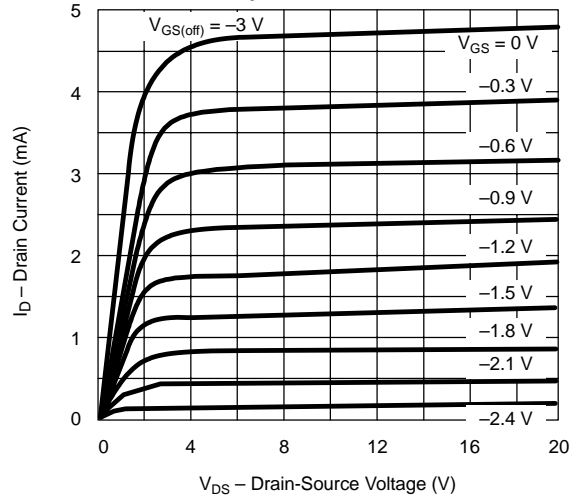
**Gate Leakage Current**



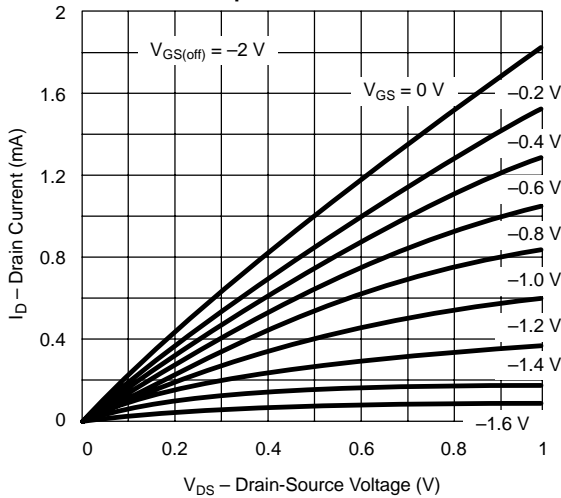
**Output Characteristics**



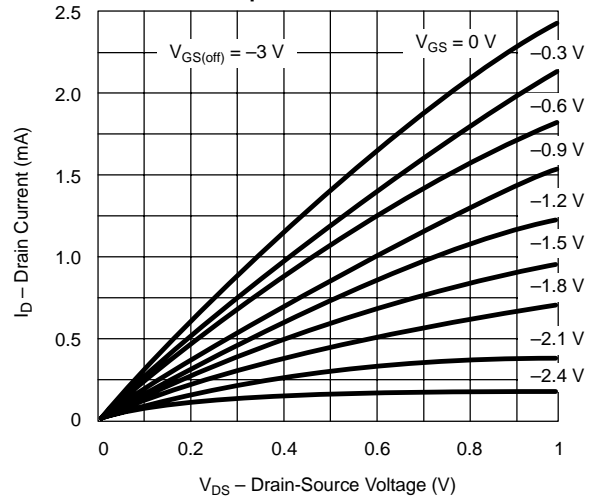
**Output Characteristics**



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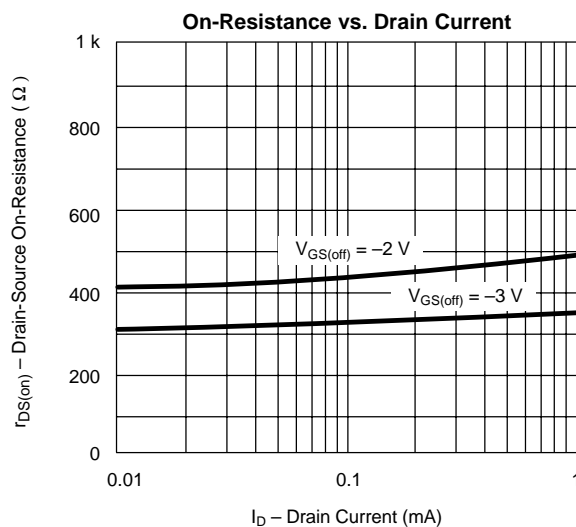
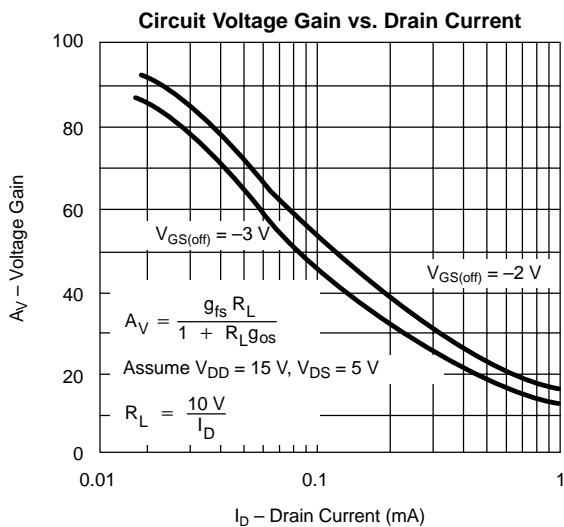
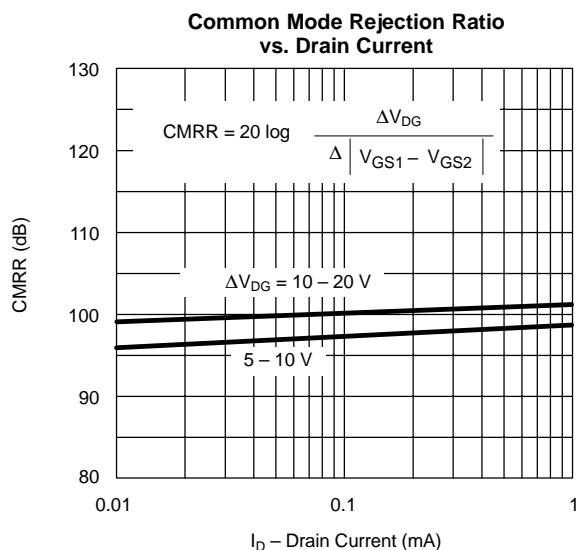
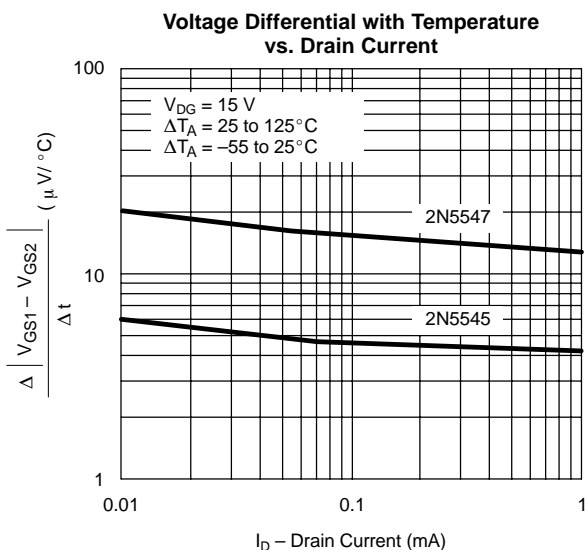
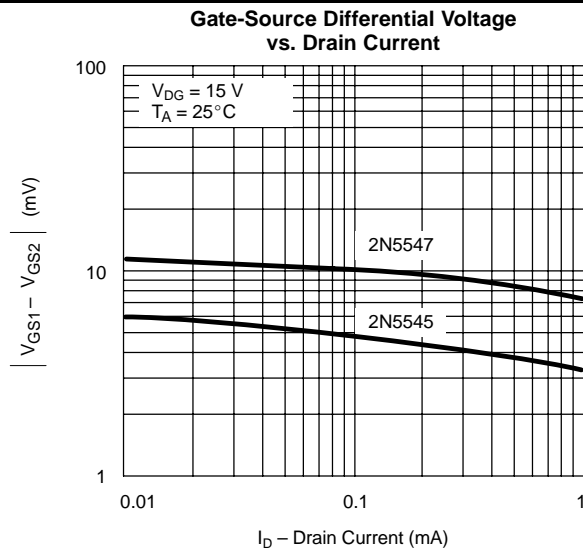
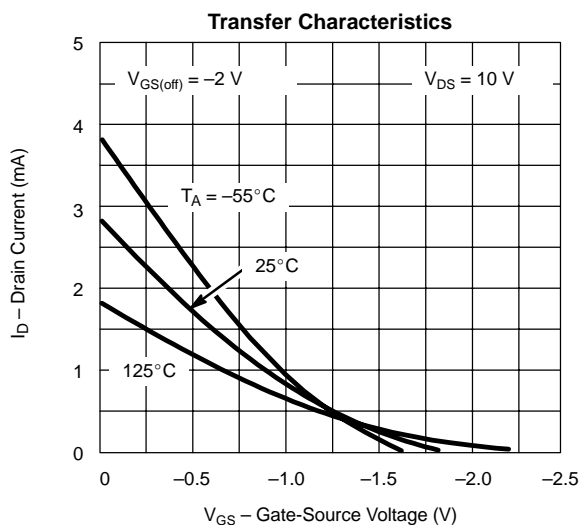


**Output Characteristics**





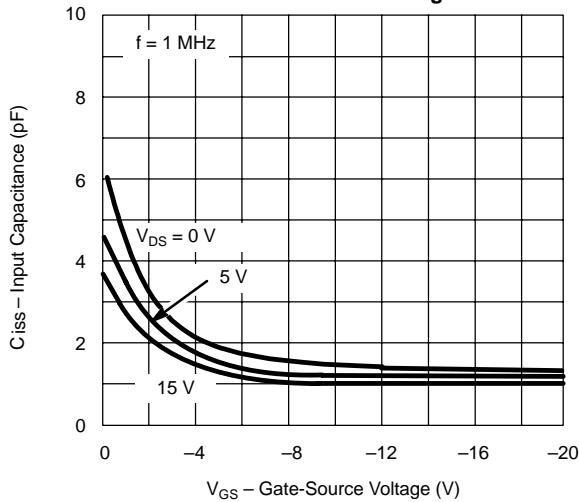
### TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)



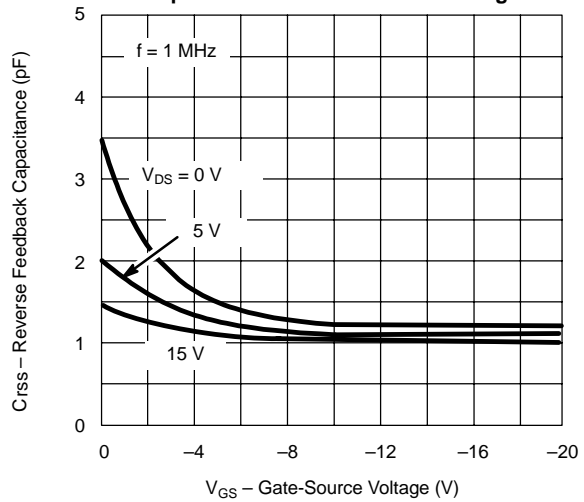


**TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)**

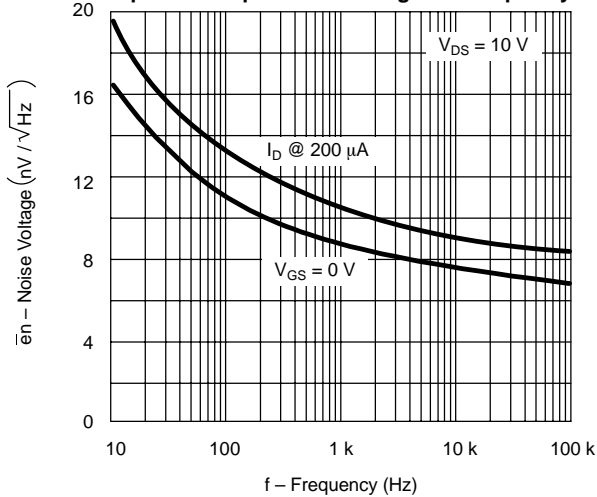
**Common-Source Input Capacitance vs. Gate-Source Voltage**



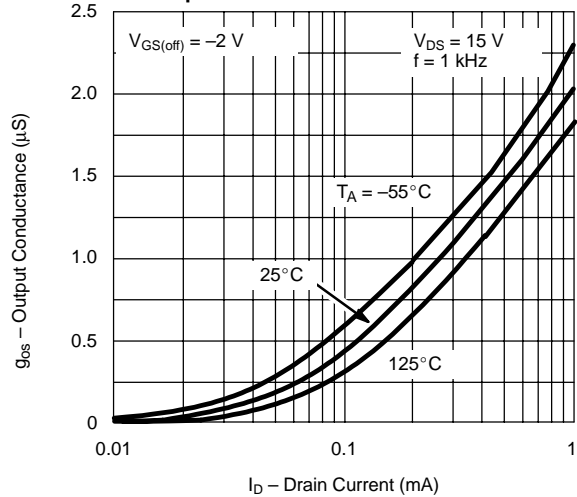
**Common-Source Reverse Feedback Capacitance vs. Gate-Source Voltage**



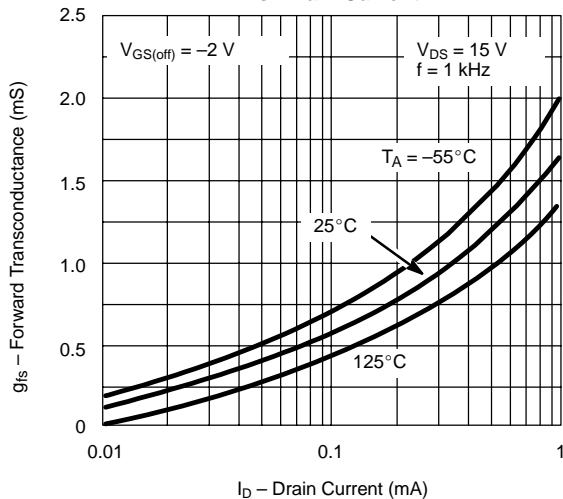
**Equivalent Input Noise Voltage vs. Frequency**



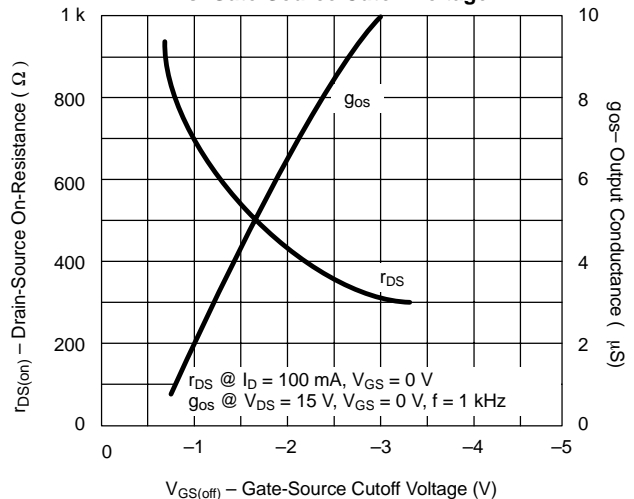
**Output Conductance vs. Drain Current**



**Common-Source Forward Transconductance vs. Drain Current**



**On-Resistance and Output Conductance vs. Gate-Source Cutoff Voltage**





## Стандарт Электрон Связь

Мы молодая и активно развивающаяся компания в области поставок электронных компонентов. Мы поставляем электронные компоненты отечественного и импортного производства напрямую от производителей и с крупнейших складов мира.

Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

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### Наши контакты:

**Телефон:** +7 812 627 14 35

**Электронная почта:** [sales@st-electron.ru](mailto:sales@st-electron.ru)

**Адрес:** 198099, Санкт-Петербург,  
Промышленная ул, дом № 19, литера Н,  
помещение 100-Н Офис 331